

Search Notes

Application/Control No.

10/537,471

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

DWARS ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	175	2/2007	JSC
430	176	↓	↓
430	302	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH IN FILE	2/2007	JSC